EM Side-Channel Attacks on SoCs

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Basics of EM side-channel attacks

- Exploit the electromagnetic emanations from an electronic device [1]
- Powerful hardware attacks
- Non-Invasive
- Higher SNR than power attacks
- Successful against cryptographic implementations [2]
- Goal: Extract secret key

Setup

- Spectrum analyzer / oscilloscope
- Pre-amplifier (plus hardware filters)
- Near field probe
- Equipment under test (EUT)



Figure 1: Magnetic field probe orientation and position affect measurement amplitude. [3]



Figure 2: Measuring setup [4]

- 1. Measure the emitted electromagnetic radiation
- 2. Preprocessing
- 3. Signal analysis (hamming distance/weight)



Figure 3: EM-based attacks [1]

- 1. Simple Electromagnetic Analysis (SEMA)
 - Try to interpret the data traces directly
 - Simple and fast

2. Differential Electromagnetic Analysis (DEMA)

- Collect large numbers of traces
- Run differential statistical methods on the data to identify correlations
- More robust but also more complicated

Introduction

- Investigate electromagnetic-based leakage from executing cryptographic workloads on...
 - 1. AES executed by an OpenSSL server on the ARM core
 - 2. the proprietary AES co-processor
 - 3. the NEON core, including bit-sliced AES

Background

- BeagleBone Black Board
- with AM335x "Sitara" SoC
- Sub-systems communicate via NoC
- Focus on
 - 1. MPU
 - 2. cryptographic co-processor (lacks public documentation)



Figure 4: BeagleBone Black with AM3358 Sitara [5]

Leakage detection

Test Vector Leakage Assessment (TVLA) [6]

- Construct two sets of test vectors
 - V₀ (single (semi-)fixed vector)
 - V_1 (large number of uniformly random chosen vectors)

• Steps:

- 1. Randomly select a test vector type $b \stackrel{s}{\leftarrow} 0, 1$
- 2. Randomly select a test vector from the chosen set $x_i \stackrel{s}{\leftarrow} V_b$
- Process the vector and add the resulting trace λ_i to a set Λ_b
- 4. Compute the t-statistic trace $t = \frac{\bar{\Lambda}_0 \bar{\Lambda}_1}{\sqrt{\frac{\sigma_0^2}{|\Lambda_0|} + \frac{\sigma_1^2}{|\Lambda_1|}}}$
- 5. Check if $|t[j]| > \tau$
- 6. If yes, significant leakage is detected at the j-th sample



Figure 5: Fixed-versus-random test [7]

Software-based AES

Imagine target device as a communications device engaged in a TLS-based session with an OpenSSL server executing AES in software

- Attacker can observe $c_i = DUT_k^{AES-128-CBC}(m_i) \rightsquigarrow \lambda_i$
 - AES-128 encryption, in CBC mode
 - unknown plaintext m_i
 - key k
 - known ciphertext c_i (since it its communicated across the network)

- Manual scan of the SoC surface
- While executing three kernels
 - 1. A set of memory intensive operations
 - 2. A spin-lock
 - 3. A set of computationally intensive operations (AES encryption)
- Cycling through the kernels and monitoring the frequency response





Probe location

- Two regions identified
 - 1. Memory intensive kernel (No further investigation)
 - 2. Centrally on the AM335x



Figure 7: BeagleBone Black schematic. Front-side on the left, back-side on the right [7]

Interrupt detection and synchronisation

- The OS may preempt a user process
- Automate identification using the trace alignment scores
 - 1. Manually identify an uninterrupted trace \rightarrow template
 - 2. Perform coarse alignment
 - 3. Calculate the least squares score
 - 4. If score > threshold \rightarrow interrupted
- Two choices
 - 1. Discarding
 - 2. Cleaning (pruning the interrupted region)



Figure 8: Impact of interrupts on the acquisition process [7]

Clock scaling

- OS scales the clock frequency, to optimise power consumption
- Stabilise at 600 MHz once the OpenSSL process became active
- Create templates at each clock frequency
- Comparison between target and template trace reveals the clock frequency used and yields a subset of traces with the same clock frequency



Figure 9: Impact of clock scaling on acquisition process [7]

- Acquisition phase
 - 1. Bulk acquire n = 1000 traces, each with l = 256 encryptions $\rightarrow 4$ kB of traffic per trace
 - 2. Deal with systemic noise (filtering for interrupts and clock scaling) \rightarrow discarding $\sim 20\%$
 - 3. From each trace, extract a fragment for each encryption operation; match with the associated ciphertexts
 - 4. Realign each sub-trace; discard any low-quality cases ightarrow discarding $\sim 5\%$
- Took $\sim 6 min$
- Next step: Exploit the leakage

- Single-bit correlation-based attack
- Target the S-box look-up in the final AES round
- Correct hypothesis can be clearly distinguished using around 20.000 sub-traces (\sim 100 traces)



Figure 10: Single-bit correlation. [7]

Hardware-based AES

- Focus on hardware-based execution of AES
- Using the cryptographic co-processor
- Attacker still can observe $c_i = DUT_k^{AES-128-CBC}(m_i) \rightsquigarrow \lambda_i$
- Imagine as Full Disk Encryption (FDE)
 - c_i is known because it lies as ciphertext on a readable disk

- Scant documentation of the cryptographic co-processor
- Unclear how AES is computed
- No identifiable periodic leakage signature found
- Failed to locate leakage
 - Fixed-versus-random test with probe locations from attack 1 failed
 - Manual scan of the AM335x surface failed

- Managed to detect the DMA strobes
- Not usable as a synchronous trigger because any memory intensive instruction can cause false positives
- Solution
 - Saturating the DMA engine with other work
 - Forces driver into a non-DMA fall-back mode \rightarrow issues interrupts for any memory management
 - Can be used as a trigger for AES operations on the co-processor
- With the trigger mechanism active, several probes were placed at various locations and leakage tests were executed → success with hamming distance

Analysis - Acquisition

- Acquisition phase was performed as follows:
 - 1. Saturate the DMA mechanism so that non-DMA fall-back mode is used
 - Acquire n = 500.000 traces, each with 1 encryption and l = 1.000 trials; match these traces with the ciphertexts
 - Apply wavelet post-processing to each trace to maximise SNR
- The acquisition took around 3 days
- To exploit: single-bit correlation-based attack
- Succeeded in recovering k



Figure 11: Single-bit correlation. [7]

- Effort to identify leakage far outweighs that of acquisition and attack phases
- Initial failure because
 - $\bullet\,$ the trigger mechanism is not accurate enough to align traces correctly and/or
 - the co-processor is protected against side-channel attacks (if yes, it is not clear which countermeasures)

NEON

- NEON is a general-purpose SIMD extension to Cortex A-series ARM cores
- To accelerate cryptographic workload and deliver constant execution time
- Attacker can observe $m_i = DUT_k^{AES-128-CBC}(c_i) \rightsquigarrow \lambda_i$
- AES is realized using the NEON-based bit-sliced implementation in OpenSSL (if *c_i* 128 bytes or more)

Attack

- Experimental environment \rightarrow same as in first attack
- Key hypotheses based on Hamming weight of the intermediate state after the first round *InvSubBytes* operation
- Attack succeeds
 - $\bullet~\sim 5.000$ traces
 - requiring 5000 * 128 = 625 kB of ciphertext



Figure 12: Decryption using the NEON-based bit-sliced implementation of AES in OpenSSL [7]

Conclusions

Section	Operation	Implementation	Hardware	Trigger	Acquisitions	Data
3	Decryption	T-tables	ARM core	GPIO-based	3,000	$46\mathrm{kB}$
3	Encryption	T-tables	ARM core	Network-based	100	$400\mathrm{kB}$
4	Encryption	Hardware	Co-processor	DMA-based	500,000	$7\mathrm{GB}$
5	Decryption	Bit-sliced	NEON core	GPIO-based	5,000	$625 \mathrm{kB}$

Table 1: Summary of results.

Countermeasures

- Signal Information Reduction [8]
 - Hiding & Masking Schemes
 - Randomization and Refreshing
- Signal Strength Reduction
 - Shielding
 - Low-level Routing
 - Spatial Randomization

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